

TC7WBD125AFK

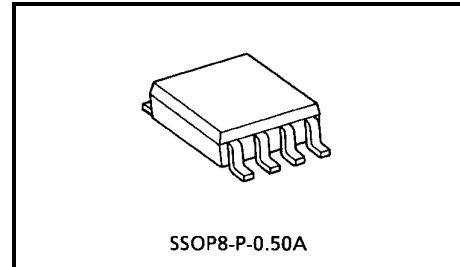
Dual Bus Switch with Level Shift

The TC7WBD125AFK is a low on-resistance, high-speed CMOS 2-bit bus switch. This bus switch allows the connections or disconnections to be made with minimal propagation delay while maintaining Low power dissipation which is the feature of CMOS.

When output enable (\overline{OE}) is at low level, the switch is on; when at high level, the switch is off.

The device is enable to realize the shift of signal level from 5 V to 3.3 V.

All inputs are equipped with protector circuits to protect the device from static discharge.

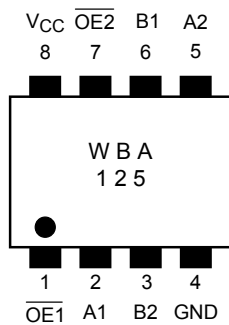


Weight: 0.01 g (typ.)

Features

- Operating voltage: $V_{CC} = 4.5\sim 5.5$ V
- High speed operation: $t_{pd} = 0.32$ ns (max)
- Ultra-low on resistance: $R_{ON} = 5 \Omega$ (typ.)
- ESD performance: Machine model $\geq \pm 200$ V
Human body model $\geq \pm 2000$ V
- TTL level input (control input)
- Low Power Dissipation: $I_{cc} = 10 \mu A$ (max.)
- Package: US8

Pin Assignment (top view)



Truth Table

Inputs	Function
OE	
L	A port = B port
H	Disconnect

System Diagram



Absolute Maximum Ratings (Note)

Characteristics	Symbol	Rating	Unit
Power supply voltage	V_{CC}	-0.5~7.0	V
Control pin input voltage	V_{IN}	-0.5~7.0	V
Switch terminal I/O voltage	V_S	-0.5~7.0	V
Clump diode current	I_{IK}	-50	mA
Switch I/O current	I_S	128	mA
Power dissipation	P_D	200	mW
DC V_{CC}/GND current	I_{CC}/I_{GND}	± 100	mA
Storage temperature	T_{stg}	-65~150	$^{\circ}C$

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Operating Ranges (Note)

Characteristics	Symbol	Rating	Unit
Power supply voltage	V_{CC}	4.5~5.5	V
Control pin input voltage	V_{IN}	0~5.5	V
Switch I/O voltage	V_S	0~5.5	V
Operating temperature	T_{opr}	-40~85	$^{\circ}C$
Control pin input rise/fall time	dt/dv	0~10	ns/V

Note: The operating ranges must be maintained to ensure the normal operation of the device.

Unused inputs must be tied to either VCC or GND.

Electrical Characteristics

DC Characteristics (Ta = -40~85°C)

Characteristics		Symbol	Test Condition	V _{CC} (V)	Min	Typ. (Note 1)	Max	Unit
Input voltage	"H" level	V _{IH}	—	4.5~5.5	2.0	—	—	V
	"L" level	V _{IL}	—	4.5~5.5	—	—	0.8	
High-level output voltage (Note 2)	V _{OH}	I _{OH} =-1μA V _{IS} = V _{CC}		4.75	2.3	2.8	3.2	V
				5.0	2.5	3.0	3.4	
				5.25	2.7	3.2	3.6	
Input leakage current	I _{IN}	V _{IN} = 0~5.5 V		4.5~5.5	—	—	±1.0	μA
Power off leakage current	I _{OFF}	A, B, \overline{OE} = 0~5.5 V		0	—	—	±1.0	μA
Off-STATE leakage current (switch off)	I _{SZ}	A, B = 0~5.5 V, \overline{OE} = V _{CC}		4.5~5.5	—	—	±1.0	μA
ON resistance (Note 3)	R _{ON}	V _{IS} = 0 V	I _{IS} = 64 mA	4.5	—	5	9	Ω
				4.75	—	5	8	
		I _{IS} = 30 mA	4.5	—	5	9		
			4.75	—	5	8		
		V _{IS} = 2.3 V, I _{IS} = 15 mA	4.5	—	35	65		
			4.75	—	35	50		
Quiescent supply current	I _{CC}	V _{IN} = V _{CC} or GND, I _{OUT} = 0		5.5	—	—	10	μA
Increase in I _{CC} per input	ΔI _{CC}	V _{IN} = 3.4 V (one input)		5.5	—	—	2.5	mA

Note 1: Typical values are at V_{CC} = 5 V, Ta = 25°C.

Note 2: It recommends that this device uses Pull-up resistance when adding and using resistance for an output terminal. Since it causes to drop a V_{OH} voltage level when using Pull-down resistance for an output terminal.

Note 3: Measured by the voltage drop between A and B pins at the indicated current through the switch. On resistance is determined by the lower of the voltages on the two (A or B) pins.

AC Characteristics (Ta = -40~85°C)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Min	Max	Unit
Propagation delay time (bus to bus)	t _{pLH} t _{pHL}	Figure 1, Figure 2 (Note)	4.5	—	0.32	ns
Output enable time	t _{pZL} t _{pZH}	Figure 1, Figure 3	4.5	—	4.5	ns
Output disable time	t _{pLZ} t _{pHZ}	Figure 1, Figure 3	4.5	—	5.0	ns

Note: The propagation delay time is calculated by the RC (on-resistance and load capacitance) time constant.

Capacitive Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Typ.	Unit	
Control pin input capacitance	C _{IN}	(Note)	5.0	3	pF	
Switch terminal capacitance	C _{I/O}	\overline{OE} = V _{CC}	(Note)	5.0	10	pF

Note: This parameter is guaranteed by design.

AC Test Circuit

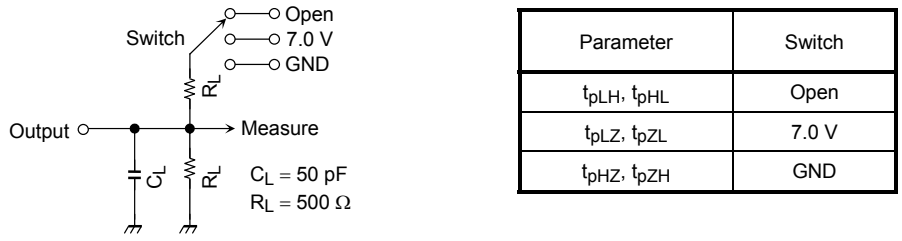


Figure 1

AC Waveform

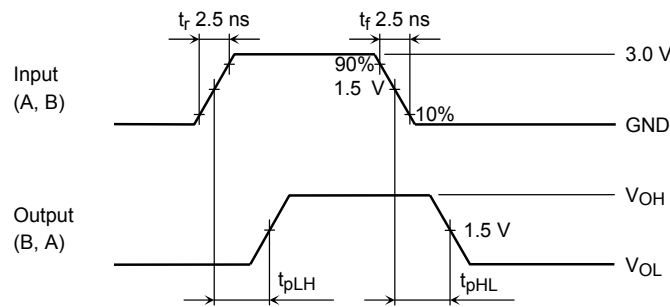


Figure 2 t_{pLH} , t_{pHL}

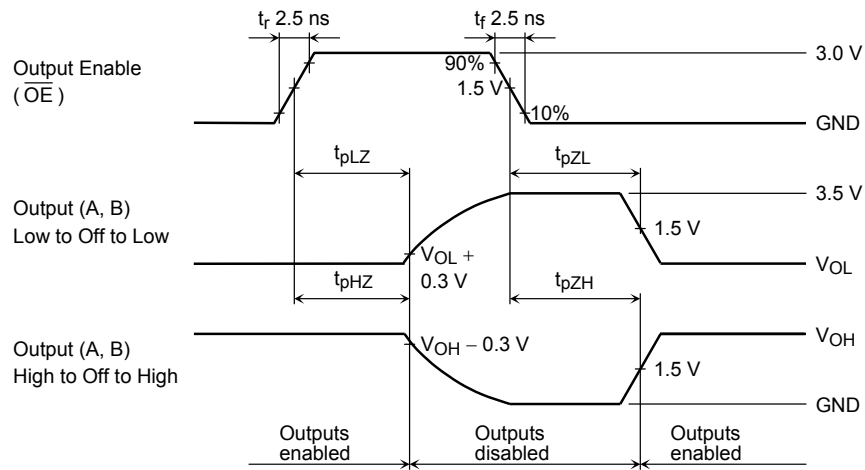


Figure 3 t_{pLZ} , t_{pHZ} , t_{pZL} , t_{pZH}

$V_{OH} - V_{CC}$ Characteristics (typ.)

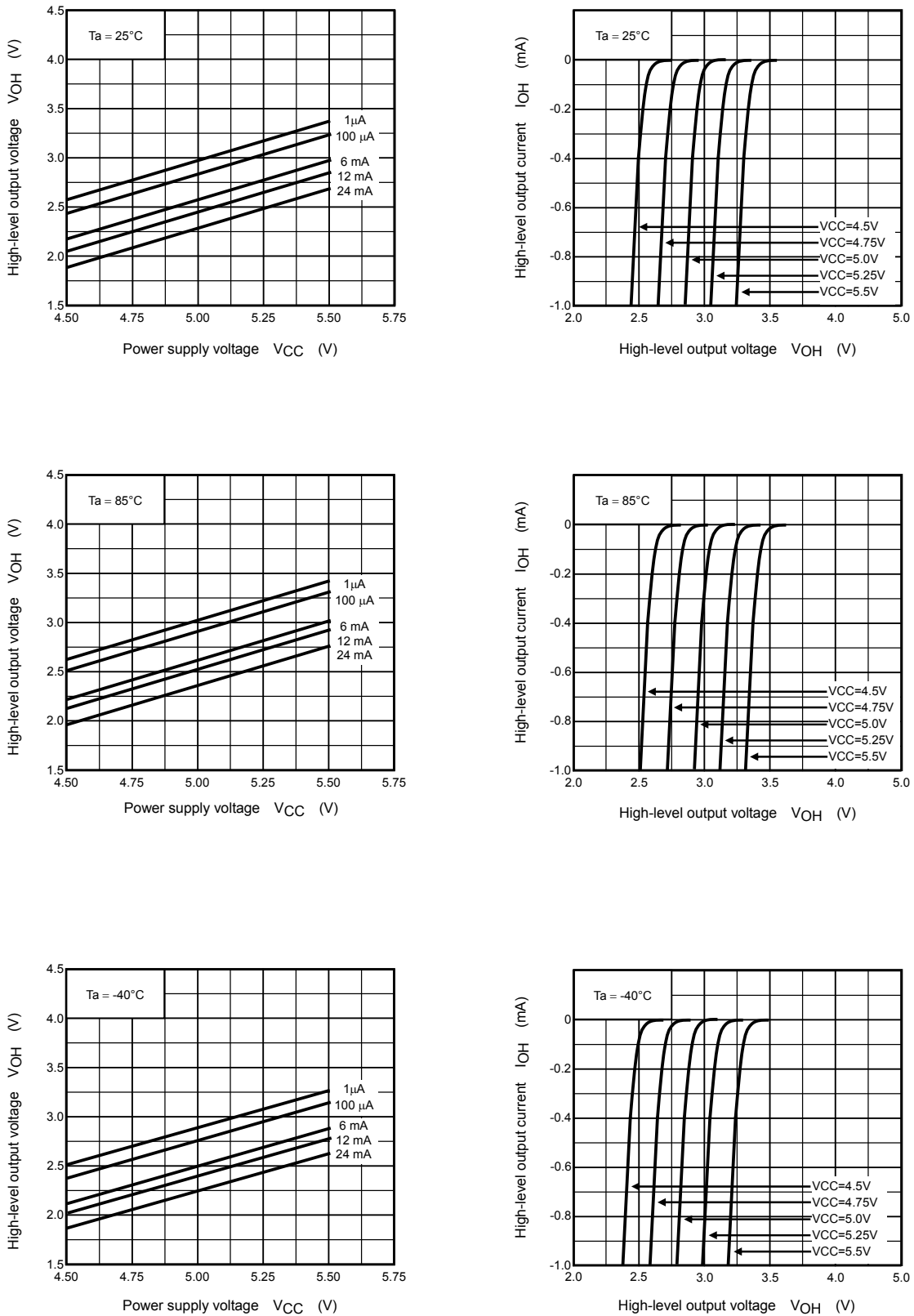
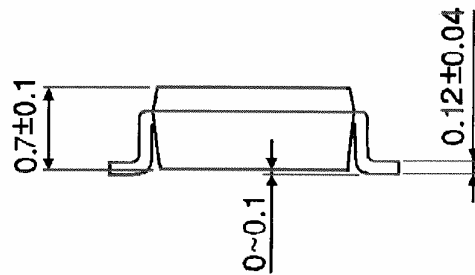
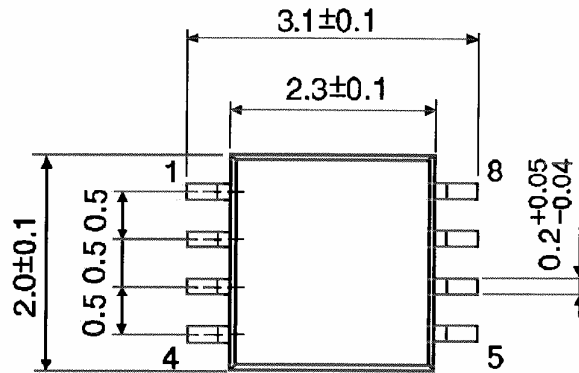


Figure 4

Package Dimensions

SSOP8-P-0.50A

Unit : mm



Weight: 0.01 g (typ.)

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20070701-EN GENERAL

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